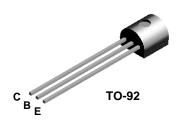


2N5551

MMBT5551





NPN General Purpose Amplifier

This device is designed for general purpose high voltage amplifiers and gas discharge display drivers.

Absolute Maximum Ratings*

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	160	V
V _{CBO}	Collector-Base Voltage	180	V
V _{EBO}	Emitter-Base Voltage	6.0	V
Ic	Collector Current - Continuous	600	mA
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

1) These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics

TA = 25°C unless otherwise noted

Symbol	Characteristic	Max		Units
		2N5551	*MMBT5551	
P _D	Total Device Dissipation	625	350	mW
	Derate above 25°C	5.0	2.8	mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case	83.3		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	357	°C/W

^{*}Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

NPN General Purpose Amplifier

20

250

8.0

50

рF

dB

(continued)

Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHA	RACTERISTICS				
V _{(BR)CEO}	Collector-Emitter Sustaining Voltage*	$I_C = 1.0 \text{ mA}, I_B = 0$	160		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_C = 100 \mu A, I_E = 0$	180		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_E = 10 \mu\text{A}, I_C = 0$	6.0		V
I _{CBO}	Collector Cutoff Current	$V_{CB} = 120 \text{ V}, I_{E} = 0,$ $V_{CB} = 120 \text{ V}, I_{E} = 0, T_{A} = 100^{\circ}\text{C}$		50 50	nA uA
I _{EBO}	Emitter Cutoff Current	$V_{EB} = 4.0 \text{ V}, I_{C} = 0$		50	nA
h _{FE}	DC Current Gain	$I_C = 1.0 \text{ mA}, V_{CE} = 5.0 \text{ V}$ $I_C = 10 \text{ mA}, V_{CE} = 5.0 \text{ V}$	80 80 30	250	
V _{CE(sat)}	Collector-Emitter Saturation Voltage	$I_C = 50 \text{ mA}, V_{CE} = 5.0 \text{ V}$ $I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$ $I_C = 50 \text{ mA}, I_B = 5.0 \text{ mA}$	30	0.15 0.20	V
$V_{\text{BE(sat)}}$	Base-Emitter Saturation Voltage	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$ $I_C = 50 \text{ mA}, I_B = 5.0 \text{ mA}$		1.0 1.0	V V
	GNAL CHARACTERISTICS	1 40 4 1/4 40 1/4	400		
SMALL SI	Current Gain - Bandwidth Product	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V},$ f = 100 MHz	100	300	MHz
		, 52	100	300 6.0	MHz pF

Noise Figure

Input Capacitance

Small-Signal Current Gain

Spice Model

 C_{ibo}

 h_{fe}

NF

 $NPN \, (Is=2.511f \ Xti=3 \ Eg=1.11 \ Vaf=100 \ Bf=242.6 \ Ne=1.249 \ Is=2.511f \ Ikf=.3458 \ Xtb=1.5 \ Br=3.197 \ Nc=2 \ Isc=0 \ Ikr=0 \ Rc=1 \ Cjc=4.883p \ Mjc=.3047 \ Vjc=.75 \ Fc=.5 \ Cje=18.79p \ Mje=.3416 \ Vje=.75 \ Tr=1.202n \ Tf=560p \ Itf=50m \ Vtf=5 \ Xtf=8 \ Rb=10)$

 $V_{BE} = 0.5 \text{ V}, I_{C} = 0,$

 $I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V},$

 I_C = 250 μA, V_{CE} = 5.0 V, R_S =1.0 kΩ, f=10 Hz to 15.7 kHz

f = 1.0 MHz

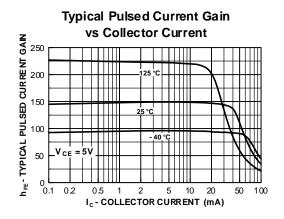
f = 1.0 kHz

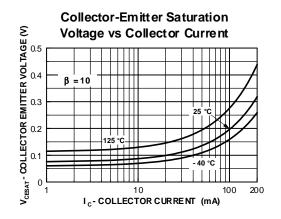
^{*}Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

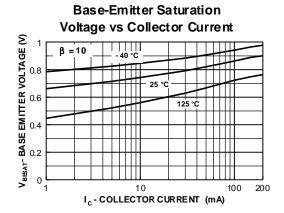
NPN General Purpose Amplifier

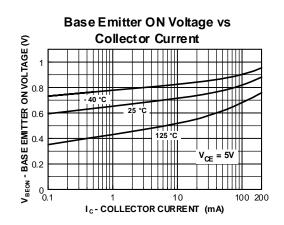
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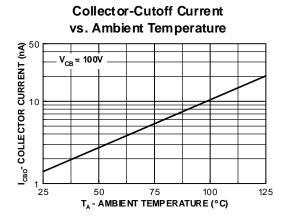
Typical Characteristics

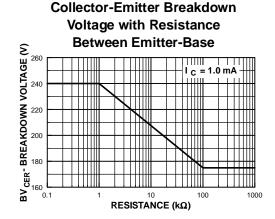










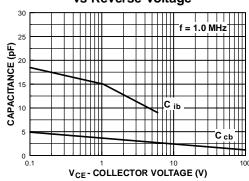


NPN General Purpose Amplifier

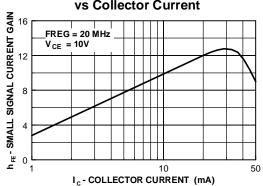
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Typical Characteristics (continued)

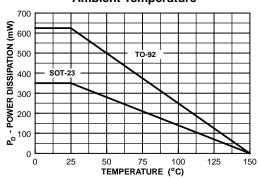
Input and Output Capacitance vs Reverse Voltage



Small Signal Current Gain vs Collector Current



Power Dissipation vs Ambient Temperature



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DOME™ ISOPLANAR™ Quiet Series™

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PRODUCT STATUS DEFINITIONS

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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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